

Search Notes

Application/Control No.

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Examiner

Junghwa M. Im

Applicant(s)/Patent under
Reexamination

BAYAN ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
updated	previous search	11/21/2005	JMI

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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